

THYRISTORS

BTY79 SERIES

Glass-passivated silicon thyristors in metal envelopes, intended for use in power control circuits (e.g. light and motor control) and power switching systems. The series consists of reverse polarity types (anode to stud) identified by a suffix R: BTY79-400R to 1000R.

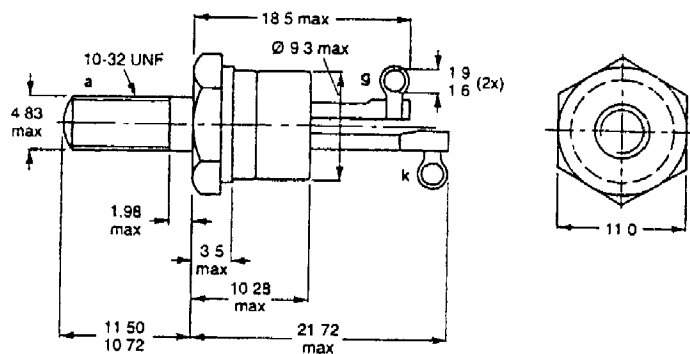
QUICK REFERENCE DATA

| | BTY79-400R | 500R | 600R | 800R | 1000R |
|-------------------------------------------------|------------|------|-----------------|-------|--------|
| Repetitive peak voltages V_{DRM}/V_{RRM} max. | 400 | 500 | 600 | 800 | 1000 V |
| Average on-state current | | | $I_T(AV)$ max. | 10 A | |
| R.M.S. on-state current | | | $I_T(RMS)$ max. | 16 A | |
| Non-repetitive peak on-state current | | | I_{TSM} max. | 150 A | |

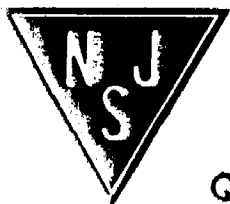
MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-64: with 10-32 UNF stud (ϕ 4,83 mm).



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BTY79 SERIES

RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Anode to cathode

| | | BTY79-400R | 500R | 600R | 800R | 1000R |
|-------------------------------------------------------------------------------------------------------------------------------------|------------------------|------------|------|------|------|----------------------|
| Non-repetitive peak off-state voltage ($t \leq 10$ ms) | V_{DSM}^{**} max. | 500 | 1100 | 1100 | 1100 | 1100 V |
| Non-repetitive peak reverse voltage ($t \leq 5$ ms) | V_{RSM} max. | 500 | 600 | 720 | 960 | 1100 V |
| Repetitive peak voltages | V_{DRM}/V_{RRM} max. | 400 | 500 | 600 | 800 | 1000 V |
| Crest working voltages | V_{DWM}/V_{RWM} max. | 400 | 500 | 600 | 800 | 1000 V* |
| <hr/> | | | | | | |
| Average on-state current (averaged over any 20 ms period) up to $T_{mb} = 85$ °C | $I_T(AV)$ | | | | max. | 10 A |
| R.M.S. on-state current | $I_T(RMS)$ | | | | max. | 16 A |
| Repetitive peak on-state current | I_{TRM} | | | | max. | 75 A |
| Non-repetitive peak on-state current; $t = 10$ ms; half sine-wave; $T_j = 125$ °C prior to surge; with reapplied V_{RWMmax} | I_{TSM} | | | | max. | 150 A |
| $I^2 t$ for fusing ($t = 10$ ms) | $I^2 t$ | | | | max. | 112 A ² s |
| Rate of rise of on-state current after triggering with $I_G = 150$ mA to $I_T = 30$ A; $dI_G/dt = 0,25$ A/ μ s | dI_T/dt | | | | max. | 50 A/ μ s |
| <hr/> | | | | | | |
| Gate to cathode | | | | | | |
| Average power dissipation (averaged over any 20 ms period) | $P_G(AV)$ | | | | max. | 0,5 W |
| Peak power dissipation | P_{GM} | | | | max. | 5 W |
| <hr/> | | | | | | |
| Temperatures | | | | | | |
| Storage temperature | T_{stg} | | | | | -55 to +125 °C |
| Junction temperature | T_j | | | | max. | 125 °C |
| <hr/> | | | | | | |
| THERMAL RESISTANCE | | | | | | |
| From junction to mounting base | $R_{th j-mb}$ | = | | | | 1,8 °C/W |
| From mounting base to heatsink with heatsink compound | $R_{th mb-h}$ | = | | | | 0,5 °C/W |
| From junction to ambient in free air | $R_{th j-a}$ | = | | | | 45 °C/W |
| Transient thermal impedance ($t = 1$ ms) | $Z_{th j-mb}$ | = | | | | 0,1 °C/W |

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CHARACTERISTICS

Anode to cathode

On-state voltage (measured under pulse conditions)
 $I_T = 20 \text{ A}; T_j = 25 \text{ }^\circ\text{C}$

$$V_T < 2 \text{ V}$$

Rate of rise of off-state voltage that will not trigger any device; exponential method;
 $V_D = 2/3 V_{DRMmax}; T_j = 125 \text{ }^\circ\text{C}$

$$dV_D/dt < 200 \text{ V}/\mu\text{s}$$

Reverse current

$V_R = V_{RWMmax}; T_j = 125 \text{ }^\circ\text{C}$

$$I_R < 3 \text{ mA}$$

Off-state current

$V_D = V_{DWMmax}; T_j = 125 \text{ }^\circ\text{C}$

$$I_D < 3 \text{ mA}$$

Latching current; $T_j = 25 \text{ }^\circ\text{C}$

$$I_L < 150 \text{ mA}$$

Holding current; $T_j = 25 \text{ }^\circ\text{C}$

$$I_H < 75 \text{ mA}$$

Gate to cathode

Voltage that will trigger all devices
 $V_D = 6 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$

$$V_{GT} > 1.5 \text{ V}$$

Voltage that will not trigger any device
 $V_D = V_{DRMmax}; T_j = 125 \text{ }^\circ\text{C}$

$$V_{GD} < 200 \text{ mV}$$

Current that will trigger all devices
 $V_D = 6 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$

$$I_{GT} > 30 \text{ mA}$$

On request (see Ordering Note)

$$I_{GT} > 20 \text{ mA}$$

Switching characteristics

Gate-controlled turn-on time ($t_{gt} = t_d + t_r$) when switched from $V_D = V_{DRMmax}$ to $I_T = 40 \text{ A}$;
 $I_{GT} = 100 \text{ mA}; dI_G/dt = 5 \text{ A}/\mu\text{s}; T_j = 25 \text{ }^\circ\text{C}$

$$t_{gt} \text{ typ. } 2 \mu\text{s}$$

Circuit-commutated turn-off time when switched from $I_T = 40 \text{ A}$ to $V_R > 50 \text{ V}$ with
 $-dI_T/dt = 10 \text{ A}/\mu\text{s}; dV_D/dt = 50 \text{ V}/\mu\text{s}; T_j = 115 \text{ }^\circ\text{C}$

$$t_q \text{ typ. } 35 \mu\text{s}$$

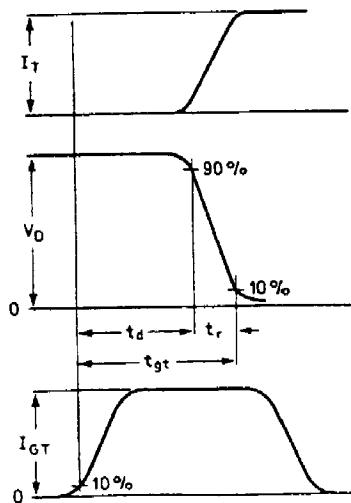


Fig. 2a Gate-controlled turn-on time definition.

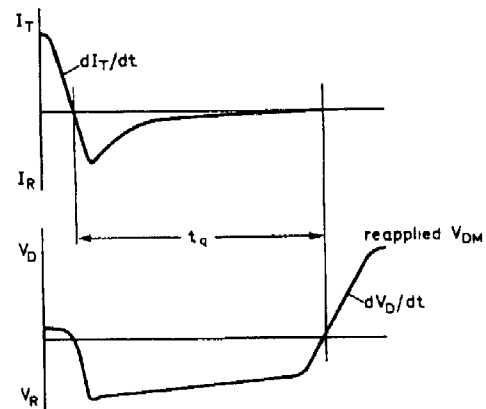


Fig. 2b Circuit-commutated turn-off time definition.